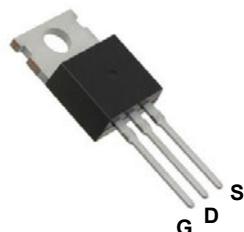
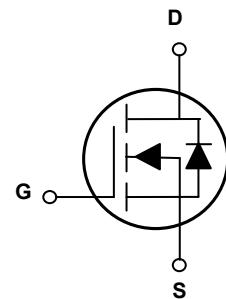


Main Product Characteristics

$V_{(BR)DSS}$	950V
$R_{DS(ON)}$	1.2Ω (Max.)
I_D	5A



TO-220



Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Low drain-to-source voltage drop ($V_{DS(on)}$)
- Fast switching and reverse body recovery



Description

The GSFH9506 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

Absolute Maximum Ratings ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	V_{DS}	950	V
Gate-Source Voltage	V_{GS}	± 30	V
Drain Current-Continuous ¹ ($T_C=25^\circ\text{C}$)	I_D	5	A
Drain Current-Continuous ¹ ($T_C=100^\circ\text{C}$)		3.2	
Drain Current-Pulsed ² ($T_C=25^\circ\text{C}$)	$I_{D,pulse}$	15	A
Continuous Diode Forward Current ¹ ($T_C=25^\circ\text{C}$)	I_S	5	A
Diode Pulsed Current ² ($T_C=25^\circ\text{C}$)	$I_{S,pulse}$	15	A
Power Dissipation ³ ($T_C=25^\circ\text{C}$)	P_D	83	W
Single Pulsed Avalanche Energy ⁴	E_{AS}	160	mJ
MOSFET dv/dt Ruggedness, $V_{DS}=0-480\text{V}$	dv/dt	50	V/ns
Reverse Diode dv/dt, $V_{DS}=0-480\text{V}$, $I_{SD} \leq I_D$	dv/dt	15	V/ns
Thermal Resistance, Junction-to-Ambient	R_{JA}	62	°C/W
Thermal Resistance, Junction-to-Case	R_{JC}	1.5	°C/W
Junction Temperature Range	T_J	-55 To +150	°C
Storage Temperature Range	T_{STG}	-55 To +150	°C

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
On / Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	950	-	-	V
Drain-Source Leakage Current	$I_{\text{DS}(\text{SS})}$	$V_{\text{DS}}=950\text{V}, V_{\text{GS}}=0\text{V}$	-	-	10	μA
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 30\text{V}$	-	-	± 100	nA
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=2\text{A}$	-	0.92	1.2	Ω
		$V_{\text{GS}}=10\text{V}, I_{\text{D}}=2\text{A}, T_J=150^\circ\text{C}$	-	2.82	-	
Gate Resistance	R_{G}	F=1MHz, Open Drain	-	29.5	-	Ω
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250\mu\text{A}$	2.9	-	3.9	V
Dynamic and Switching Characteristics						
Total Gate Charge	Q_{g}	$V_{\text{DS}}=400\text{V}, I_{\text{D}}=2.5\text{A}, V_{\text{GS}}=10\text{V}$	-	14.9	-	nC
Gate-Source Charge	Q_{gs}		-	4.8	-	
Gate-to-Drain Charge	Q_{gd}		-	3.4	-	
Gate Plateau Voltage	V_{plateau}		-	5	-	
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DS}}=400\text{V}, R_{\text{G}}=2\Omega, V_{\text{GS}}=10\text{V}, I_{\text{D}}=2.5\text{A}$	-	30	-	nS
Rise Time	t_{r}		-	14	-	
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$		-	59.6	-	
Fall Time	t_{f}		-	27.2	-	
Input Capacitance	C_{iss}	$V_{\text{DS}}=50\text{V}, V_{\text{GS}}=0\text{V}, F=100\text{kHz}$	-	878	-	pF
Output Capacitance	C_{oss}		-	34	-	
Reverse Transfer Capacitance	C_{rss}		-	1.5	-	
Effective Output Capacitance, Energy Related	$C_{\text{o(er)}}$	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}-400\text{V}$	-	21	-	
Effective Output Capacitance, Time Related	$C_{\text{o(tr)}}$		-	108	-	
Drain-Source Diode Characteristics and Maximum Ratings						
Peak Reverse Recovery Current	I_{rrm}	$V_{\text{R}}=400\text{V}, I_{\text{s}}=2.5\text{A}, \text{di/dt}=100\text{A}/\mu\text{s}$	-	15.8	-	A
Reverse Recovery Time	T_{rr}		-	216	-	ns
Reverse Recovery Charge	Q_{rr}		-	1.8	-	uC
Diode Forward Voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{s}}=5\text{A}$	-	-	1.3	V

Note:

- Calculated continuous current based on maximum allowable junction temperature.
- Repetitive rating; pulse width limited by max. junction temperature.
- P_{d} is based on max. junction temperature, using junction-case thermal resistance.
- $V_{\text{DD}}=100\text{V}, V_{\text{GS}}=10\text{V}, L=79.9\text{mH}$, starting $T_J=25^\circ\text{C}$.

Typical Electrical and Thermal Characteristic Curves

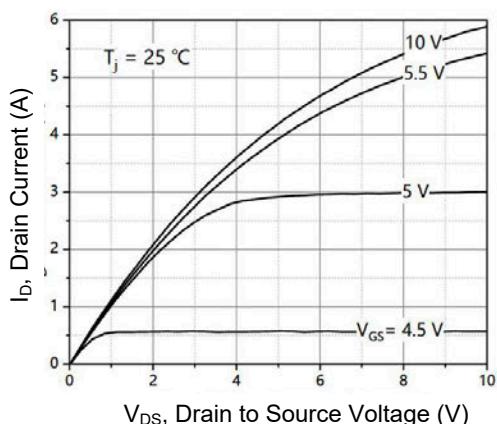


Figure 1. Output Characteristics

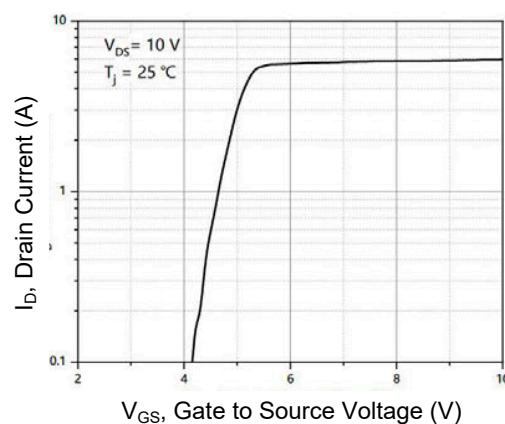


Figure 2. Transfer Characteristics

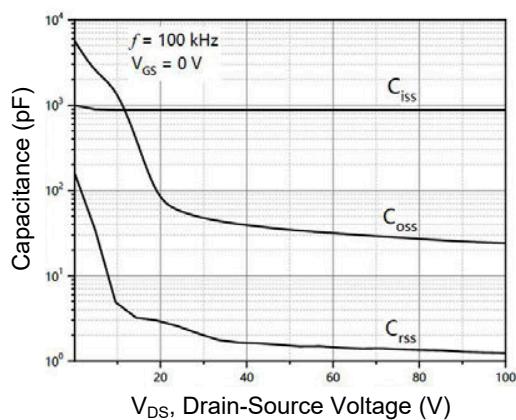


Figure 3. Capacitance Characteristics

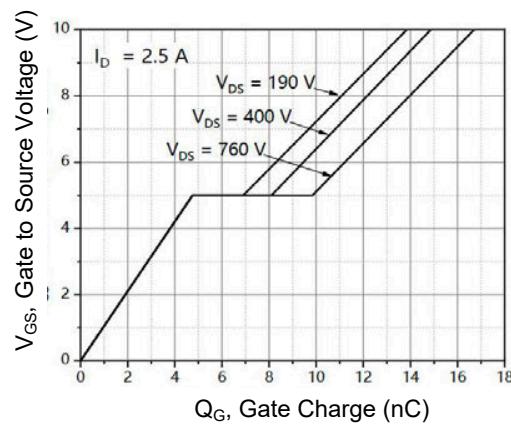


Figure 4. Gate Charge

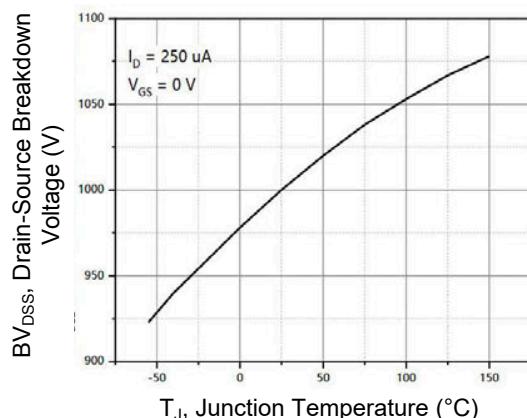


Figure 5. Drain-Source Breakdown Voltage

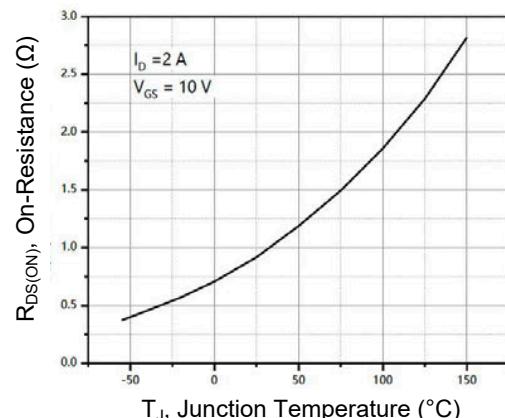


Figure 6. Drain-Source On-State Resistance

Typical Electrical and Thermal Characteristic Curves

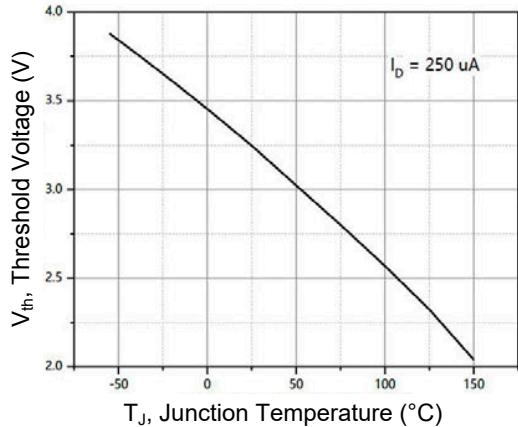


Figure 7. Threshold Voltage

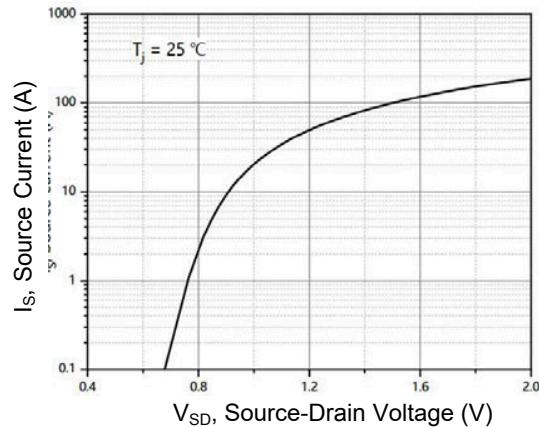


Figure 8. Forward Characteristics of Body Diode

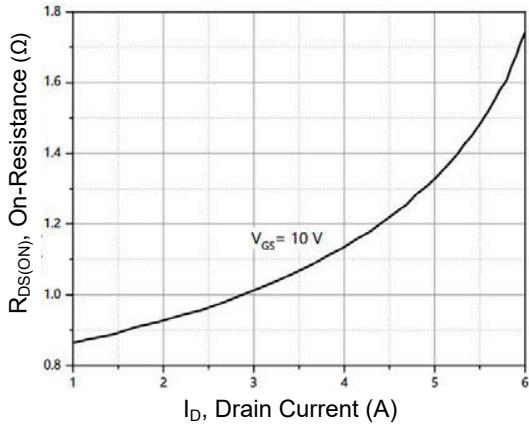


Figure 9. R_{DS(ON)} vs. Drain Current

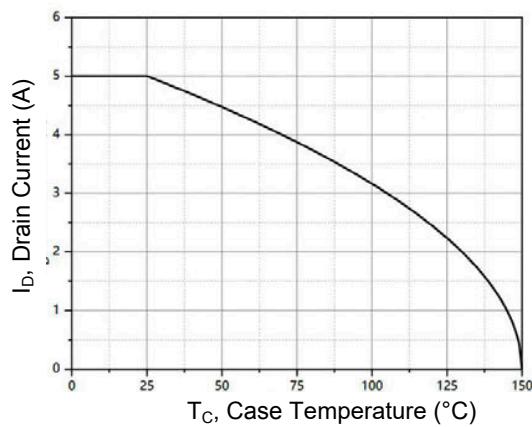


Figure 10. Drain Current

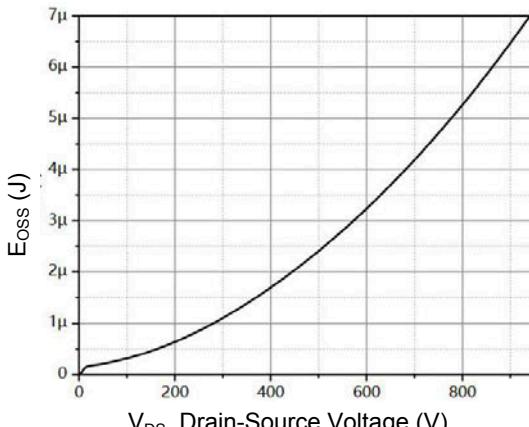


Figure 11. Typ. Coss Stored Energy

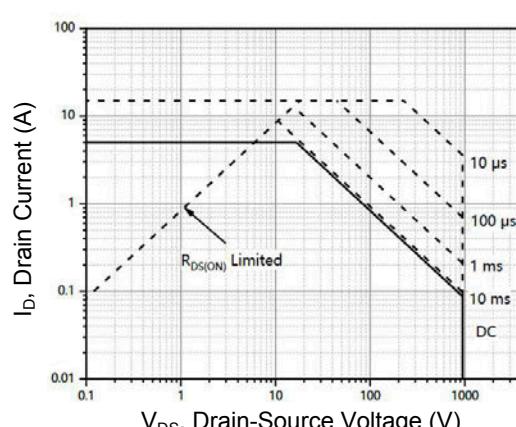


Figure 12. Safe Operation Area, T_c=25°C

Typical Electrical and Thermal Characteristic Curves

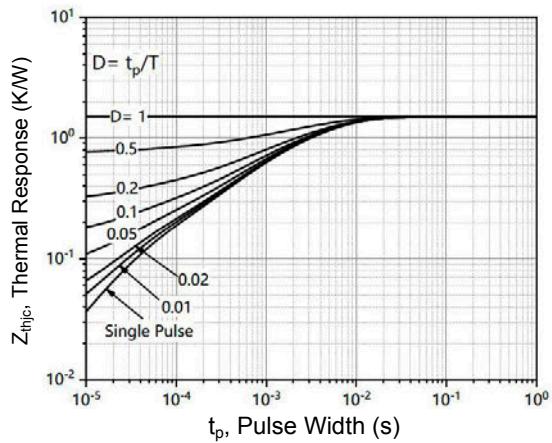
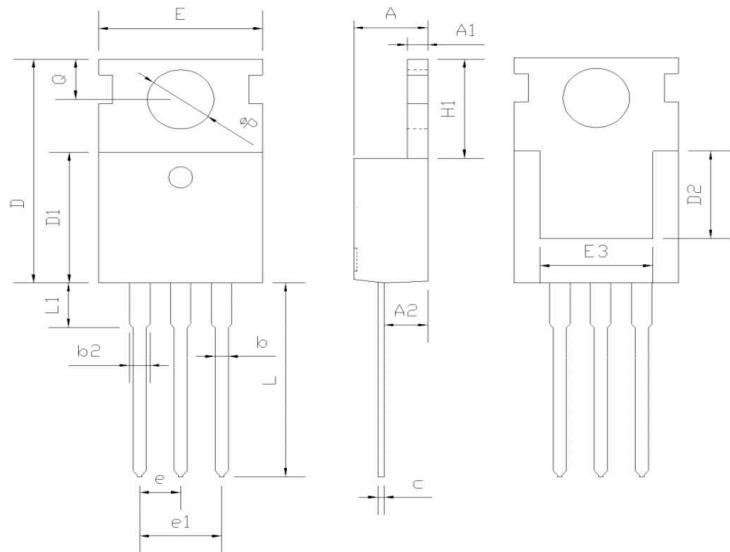


Figure 13. Max. Transient Thermal Impedance

Package Outline Dimensions (TO-220)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	4.370	4.770	0.172	0.188
A1	1.250	1.450	0.049	0.057
A2	2.200	2.600	0.087	0.102
b	0.700	0.950	0.028	0.037
b2	1.170	1.470	0.046	0.058
c	0.400	0.650	0.016	0.026
D	15.100	16.100	0.594	0.634
D1	8.800	9.400	0.346	0.370
D2	5.500	-	0.217	-
E	9.700	10.300	0.382	0.406
E3	7.000	-	0.276	-
e	2.540 BSC		0.100 BSC	
e1	5.080 BSC		0.200 BSC	
H1	6.250	6.850	0.246	0.270
L	12.750	13.800	0.502	0.543
L1	-	3.400	-	0.134
θP	3.400	3.800	0.134	0.150
Q	2.600	3.000	0.102	0.118